Dual General Purpose Transistor

The MBT3906DW1T1 device is a spin-off of our popular SOT-23/SOT-323 three-leaded device. It is designed for general purpose amplifier applications and is housed in the SOT-363 six-leaded surface mount package. By putting two discrete devices in one package, this device is ideal for low-power surface mount applications where board space is at a premium.

Features

- h_{FE}, 100–300
- Low $V_{CE(sat)}$, $\leq 0.4 \text{ V}$
- Simplifies Circuit Design
- Reduces Board Space
- Reduces Component Count
- Available in 8 mm, 7–inch/3,000 Unit Tape and Reel
- Pb–Free Package is Available

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CEO}	-40	Vdc
Collector-Base Voltage	V _{CBO}	-40	Vdc
Emitter-Base Voltage	V_{EBO}	-5.0	Vdc
Collector Current – Continuous	Ι _C	-200	mAdc
Electrostatic Discharge	ESD	HBM>16000, MM>2000	V

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

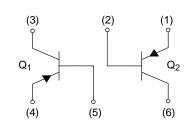
Characteristic	Symbol	Max	Unit
Total Package Dissipation (Note 1) $T_A = 25^{\circ}C$	P _D	150	mW
Thermal Resistance, Junction-to-Ambient	R_{\thetaJA}	833	°C/W
Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C

 Device mounted on FR4 glass epoxy printed circuit board using the minimum recommended footprint.



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SOT-363/SC-88 CASE 419B STYLE 1

MARKING DIAGRAM



A2 = Device Coded = Date Code

ORDERING INFORMATION

Device	Package	Shipping [†]
MBT3906DW1T1	SOT-363	3000 Units/Reel
MBT3906DW1T1G	SOT-363 (Pb-Free)	3000 Units/Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Semiconductor Components Industries, LLC, 2005 January, 2005 – Rev. 1

ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS					
Collector – Emitter Breakdown Voltage (Note 2)	V _{(BR)CEO}	-40	-	Vdc	
Collector – Base Breakdown Voltage	V _{(BR)CBO}	-40	-	Vdc	
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	-5.0	-	Vdc	
Base Cutoff Current	I _{BL}	-	-50	nAdc	
Collector Cutoff Current	I _{CEX}	-	-50	nAdc	

ON CHARACTERISTICS (Note 2)

DC Current Gain $(I_{C} = -0.1 \text{ mAdc}, V_{CE} = -1.0 \text{ Vdc})$ $(I_{C} = -1.0 \text{ mAdc}, V_{CE} = -1.0 \text{ Vdc})$	h _{FE}	60 80		-
$(I_{C} = -10 \text{ mAdc}, V_{CE} = -1.0 \text{ Vdc})$ $(I_{C} = -50 \text{ mAdc}, V_{CE} = -1.0 \text{ Vdc})$ $(I_{C} = -100 \text{ mAdc}, V_{CE} = -1.0 \text{ Vdc})$		100 60 30	300 - -	
Collector – Emitter Saturation Voltage ($I_C = -10 \text{ mAdc}, I_B = -1.0 \text{ mAdc}$) ($I_C = -50 \text{ mAdc}, I_B = -5.0 \text{ mAdc}$)	V _{CE(sat)}	-	-0.25 -0.4	Vdc
Base – Emitter Saturation Voltage $(I_C = -10 \text{ mAdc}, I_B = -1.0 \text{ mAdc})$ $(I_C = -50 \text{ mAdc}, I_B = -5.0 \text{ mAdc})$	V _{BE(sat)}	-0.65 -	-0.85 -0.95	Vdc

SMALL-SIGNAL CHARACTERISTICS

Current-Gain – Bandwidth Product	f _T	250	-	MHz
Output Capacitance	C _{obo}	-	4.5	pF
Input Capacitance	C _{ibo}	-	10.0	pF

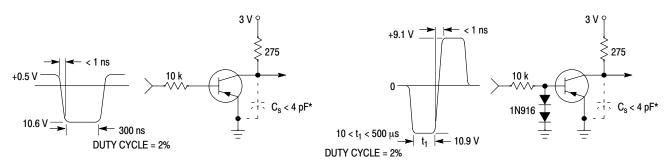
2. Pulse Test: Pulse Width \leq 300 μ s; Duty Cycle \leq 2.0%.

ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted) (Continued)

Characteristic	Symbol	Min	Max	Unit
Input Impedance ($V_{CE} = -10 \text{ Vdc}$, $I_C = -1.0 \text{ mAdc}$, f = 1.0 kHz)	h _{ie}	2.0	12	kΩ
Voltage Feedback Ratio (V _{CE} = -10 Vdc, I _C = -1.0 mAdc, f = 1.0 kHz)	h _{re}	0.1	10	X 10 ⁻⁴
Small – Signal Current Gain (V _{CE} = -10 Vdc, I _C = -1.0 mAdc, f = 1.0 kHz)	h _{fe}	100	400	-
Output Admittance ($V_{CE} = -10 \text{ Vdc}$, $I_C = -1.0 \text{ mAdc}$, f = 1.0 kHz)	h _{oe}	3.0	60	μmhos
Noise Figure (V_{CE} = -5.0 Vdc, I_C = -100 µAdc, R_S = 1.0 k Ω, f = 1.0 kHz)	NF	-	4.0	dB

SWITCHING CHARACTERISTICS

Delay Time	$(V_{CC} = -3.0 \text{ Vdc}, V_{BE} = 0.5 \text{ Vdc})$	t _d	-	35	
Rise Time	$(I_{C} = -10 \text{ mAdc}, I_{B1} = -1.0 \text{ mAdc})$	t _r	-	35	ns
Storage Time	$(V_{CC} = -3.0 \text{ Vdc}, I_C = -10 \text{ mAdc})$	t _s	-	225	
Fall Time	$(I_{B1} = I_{B2} = -1.0 \text{ mAdc})$	t _f	-	75	ns

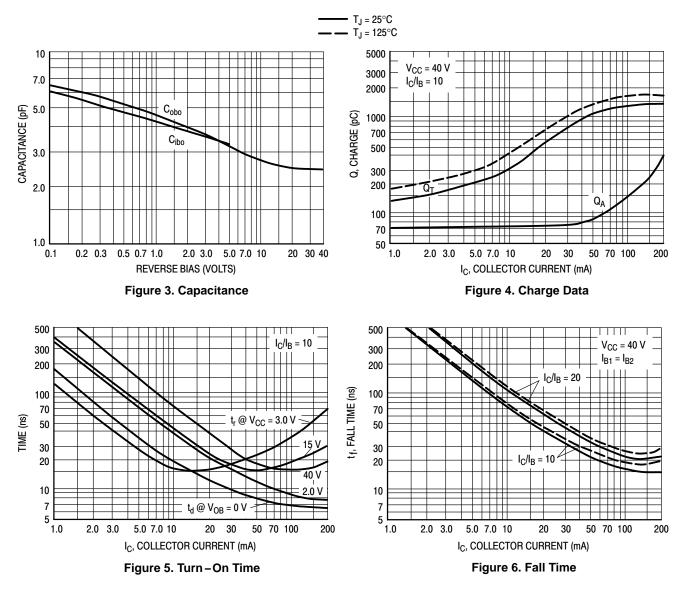


* Total shunt capacitance of test jig and connectors

Figure 1. Delay and Rise Time Equivalent Test Circuit

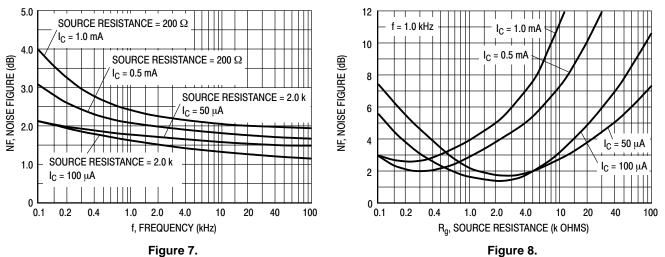
Figure 2. Storage and Fall Time Equivalent Test Circuit

TYPICAL TRANSIENT CHARACTERISTICS

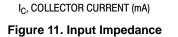




 $(V_{CE} = -5.0 \text{ Vdc}, T_A = 25^{\circ}\text{C}, \text{ Bandwidth} = 1.0 \text{ Hz})$

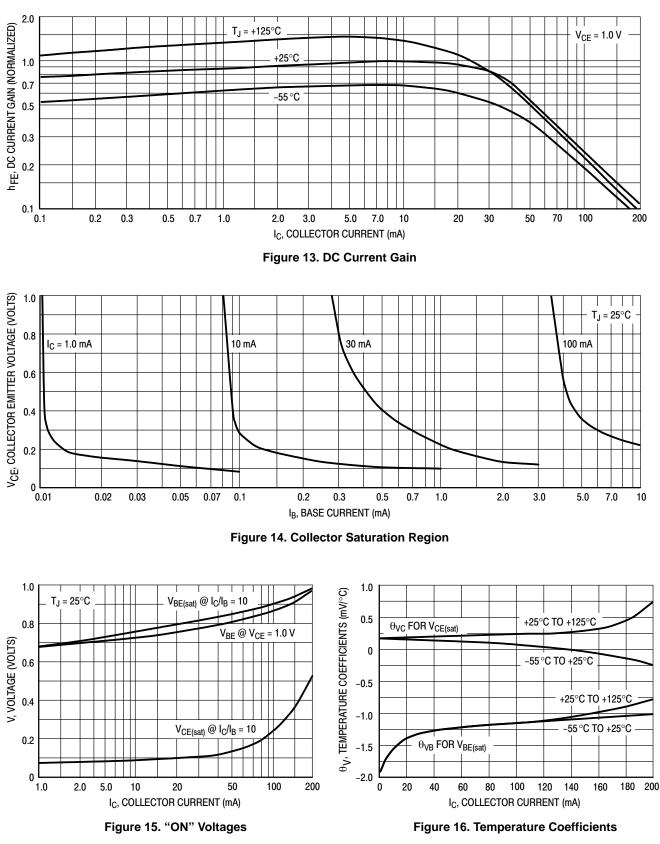


h PARAMETERS $(V_{CE} = -10 \text{ Vdc}, f = 1.0 \text{ kHz}, T_A = 25^{\circ}\text{C})$ 300 100 h_{oe}, OUTPUT ADMITTANCE (µ mhos) 70 50 hfe, DC CURRENT GAIN 200 30 20 100 70 10 50 7 30 5 3.0 0.1 0.2 0.3 0.5 0.7 1.0 2.0 3.0 5.0 7.0 10 0.1 0.2 0.3 0.5 0.7 1.0 2.0 5.0 7.0 10 IC, COLLECTOR CURRENT (mA) IC, COLLECTOR CURRENT (mA) Figure 9. Current Gain Figure 10. Output Admittance 20 , VOLTAGE FEEDBACK RATIO (x 10-4) 10 7.0 h_{ie}, INPUT IMPEDANCE (k OHMS) 10 7.0 5.0 5.0 3.0 3.0 2.0 2.0 1.0 0.7 1.0 0.5 0.7 0.3 0.2 hre 0.5 5.0 7.0 0.1 0.2 0.3 0.5 0.7 1.0 2.0 3.0 10 0.1 0.2 0.3 0.5 0.7 1.0 2.0 3.0 5.0 7.0 10



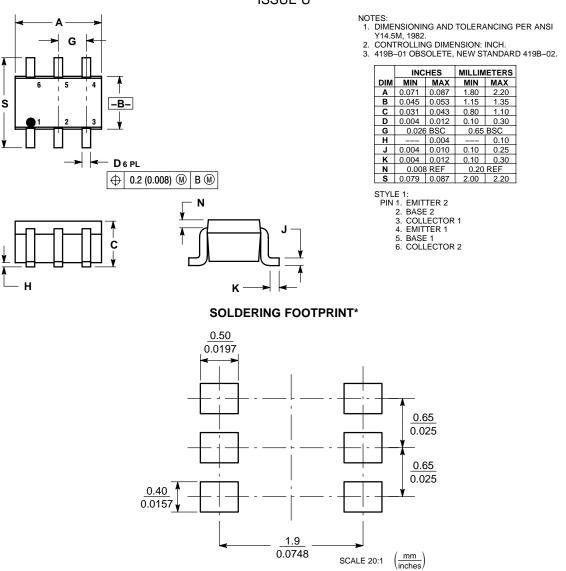






PACKAGE DIMENSIONS

SOT-363/SC-88 CASE 419B-02 ISSUE U



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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